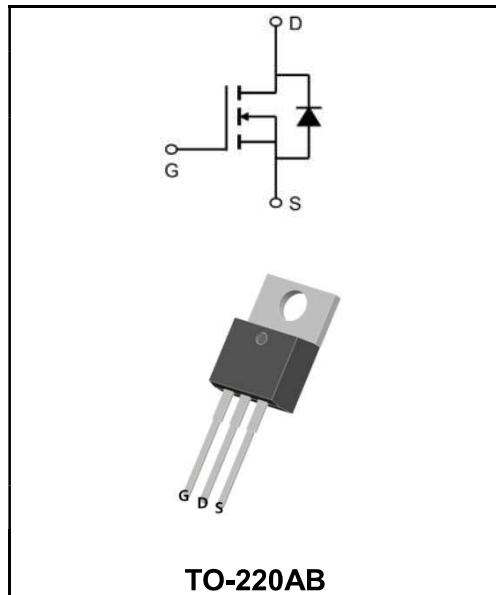


200V N-CHANNEL ENHANCEMENT MODE MOSFET
MAIN CHARACTERISTICS

I_D	18A
V_{DSS}	200V
$R_{DS(on)-typ}(@V_{GS}=10V)$	< 150mΩ (Type: 120mΩ)


Application

- ◆ Uninterruptible Power Supply(UPS)
- ◆ Power Factor Correction (PFC)

Product Specification Classification

Part Number	Package	Marking	Pack
YFW640AT	TO-220AB	YFW 640AT XXXXX	1000PCS/Tape

Maximum Ratings at $T_c=25^\circ C$ unless otherwise specified

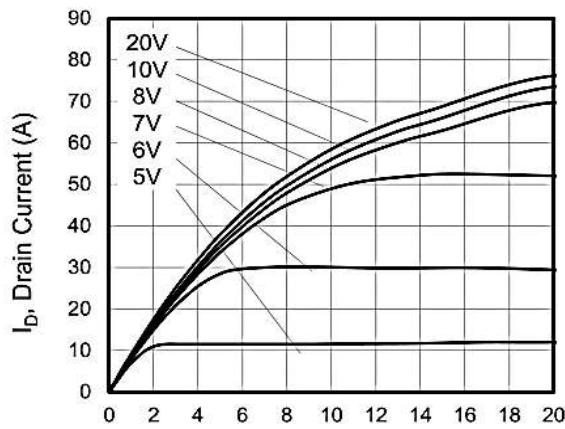
Characteristics	Symbols	Value	Units
Drain-Source Voltage($V_{GS}=0V$)	V_{DS}	200	V
Continuous Drain Current	I_D	18	A
Pulsed Drain Current (Note1)	I_{DM}	72	A
Gate - Source Voltage	V_{GS}	±20	V
Single Pulse Avalanche Energy (Note2)	E_{AS}	340	mJ
Avalanche Current (Note1)	I_{AR}	15	A
Repetitive Avalanche Energy (Note1)	E_{AR}	8.3	mJ
Power Dissipation ($T_c=25^\circ C$)	P_D	104	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C
Thermal Resistance, Junction-case	$R_{\theta JC}$	1.2	°C/W
Thermal Resistance, Junction ambient	$R_{\theta JA}$	62.5	°C/W

Maximum Ratings at T_c=25°C unless otherwise specified

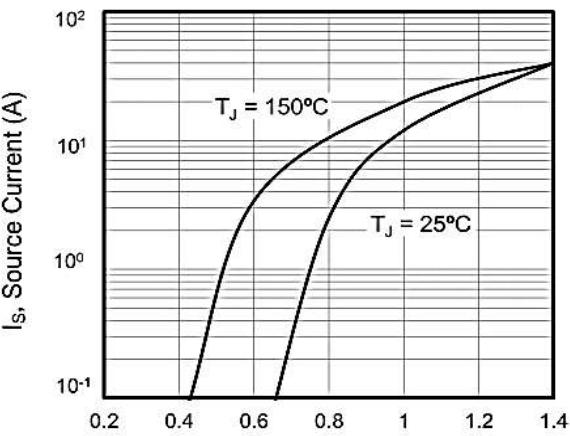
Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	V(BR)DSS	200	220	-	V
Zero Gate Voltage Drain Current	V _{DS} =200V, V _{GS} =0V, T _J = 25°C	I _{DSS}	-	-	5	μA
	V _{DS} =160V, V _{GS} =0V, T _J = 125°C		-	-	100	
Gate- Source Leakage	V _{GS} =±20V	I _{GSS}	-	-	±100	nA
Gate Source Threshold Voltage	V _{DS} = V _{GS} , I _D =250μA	V _{GS(th)}	2.0	3.0	4.0	V
Drain-Source On-Resistance (Note3)	V _{GS} =10V, I _D =9A	R _{DS(ON)}	-	120	150	mΩ
Input Capacitance	V _{DS} =25V V _{GS} =0V f=1MHz	C _{iss}	-	1318	-	pF
Output Capacitance		C _{oss}	-	180	-	
Reverse Transfer Capacitance		C _{rss}	-	75	-	
Total Gate Charge	V _{DD} =160V I _D =18A V _{GS} =10V	Q _g	-	41	-	nC
Gate-Source Charge		Q _{gs}	-	5.5	-	
Gate-Drain Charge		Q _{gd}	-	19.5	-	
Turn-on delay time	V _{DD} =100V I _D =18A R _G =25Ω	t _{d(on)}	-	24	-	ns
Turn-on Rise Time		T _r	-	45	-	
Turn-Off Delay Time		t _{d(OFF)}	-	101	-	
Turn-on Fall Time		t _f	-	95	-	
Continuous Body Diode Current	T _c = 25°C	I _s	-	-	18	A
Pulsed Diode Forward Current		I _{SM}	-	-	72	A
Body Diode Voltage	V _{GS} =0V, I _{SD} =18A, T _J = 25°C	V _{SD}	-	-	1.4	V
Reverse Recovery Time	V _{GS} =0V, I _s =18A, dI _{SD} /dt=100A/μs	t _{rr}	-	230	-	ns
Reverse Recovery Charge		Q _{rr}	-	1.8	-	nC

Note :

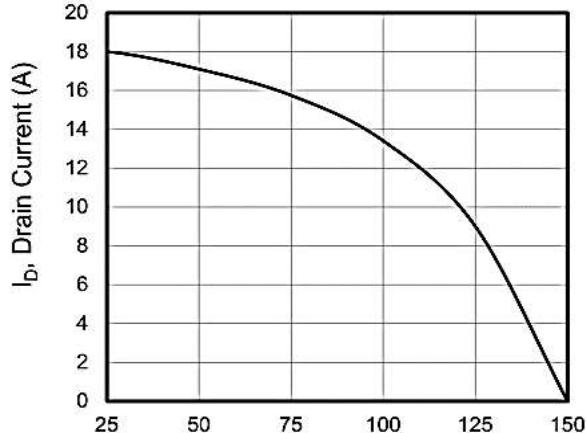
- 1、The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2、The EAS data shows Max. rating . IAS = 15A, VDD = 50V, RG = 25 Ω, Starting TJ = 25 °C
- 3、The test condition is Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%
- 4、The power dissipation is limited by 150°C junction temperature
- 5、The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

Ratings and Characteristic Curves
Typical Characteristics


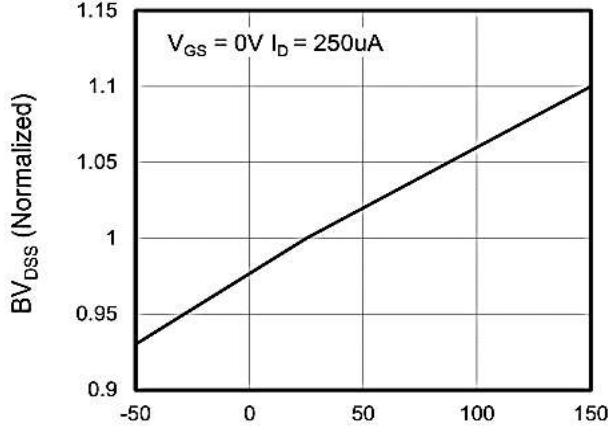
V_{DS}, Drain-to-Source Voltage (V)
Figure 1. Output Characteristics ($T_J = 25^\circ\text{C}$)



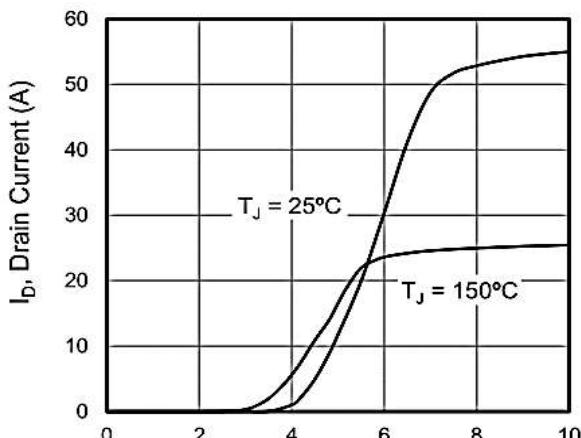
V_{SD}, Source-to-Drain Voltage (V)
Figure 2. Body Diode Forward Voltage



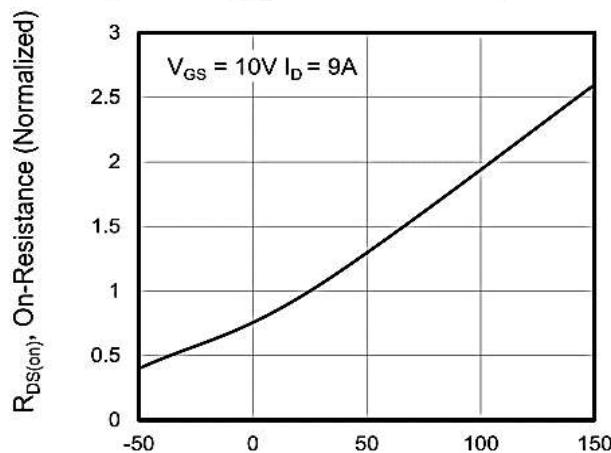
T_C, Case Temperature (A)
Figure 3. Drain Current vs. Temperature



T_J, Junction Temperature (°C)
Figure 4. BV_{DSS} Variation vs. Temperature

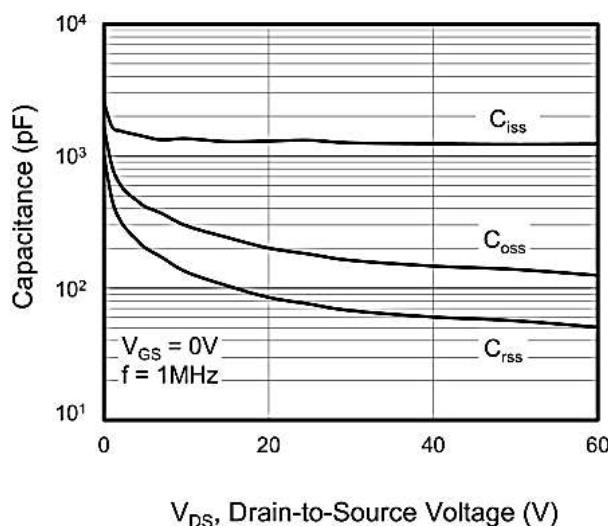


V_{GS}, Gate-to-Source Voltage (V)
Figure 5. Transfer Characteristics



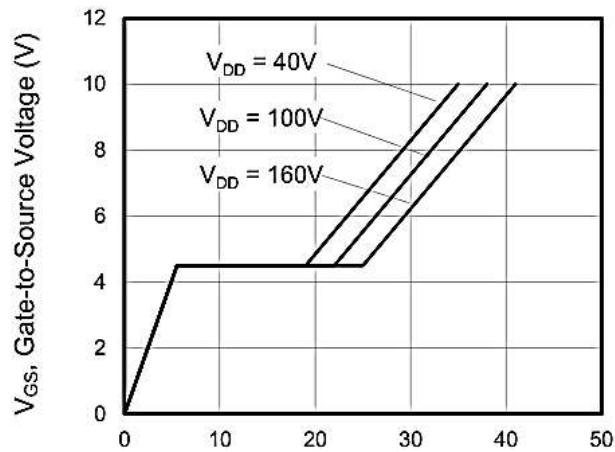
T_J, Junction Temperature (°C)
Figure 6. On-Resistance vs. Temperature

Ratings and Characteristic Curves



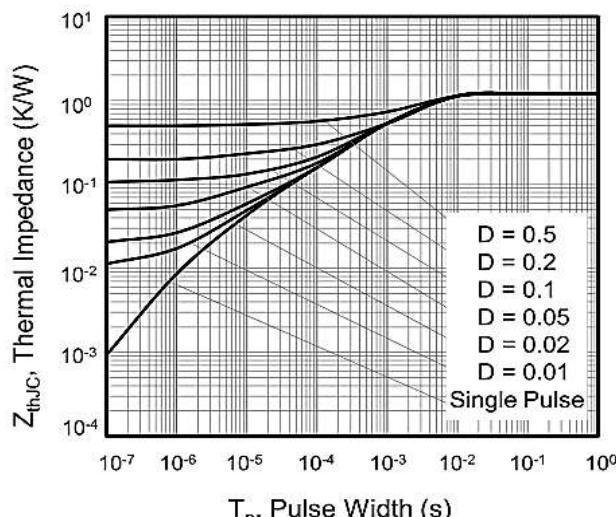
V_{DS} , Drain-to-Source Voltage (V)

Figure 7. Capacitance



Q_g , Total Gate Charge (nC)

Figure 8. Gate Charge

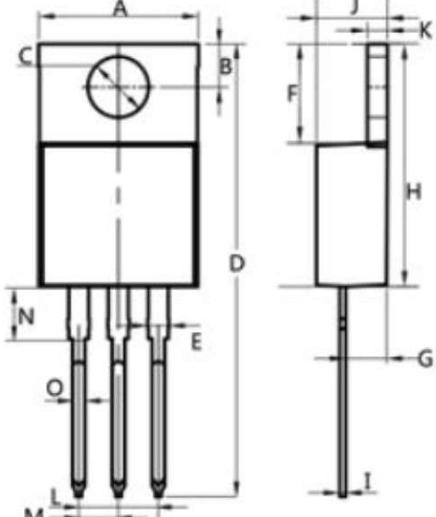


T_p , Pulse Width (s)

Figure 10. Transient Thermal Impedance

Package Outline Dimensions Millimeters

TO-220AB



Dim.	Min.	Max.
A	10.15	10.35
B	2.65	2.95
C	3.70	3.90
D	28.5	29.5
E	1.30	1.45
F	6.35	6.55
G	2.9	3.3
H	15.0	16.0
I	0.38	0.42
J	4.45	4.55
K	1.25	1.35
L	Typ 5.08	
M	Typ 2.54	
N	3.1	3.3
O	0.76	0.84

All Dimensions in millimeter